


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/696,897	LEE ET AL.	
	Examiner	Art Unit	
	Esaw T. Abraham	2133	

SEARCHED			
Class	Subclass	Date	Examiner
714	752, 801, 794	4/27/2006	EA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (USPT, JPO, EPO, DERWENT) (for text search) see search printout history.	4/27/2006	EA